

<b>Notice of References Cited</b>	Application/Control No. 10/764,660	Applicant(s)/Patent Under Reexamination HONG, SOON-HAC	
	Examiner ERIC A. WIENER	Art Unit 2179	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0146250 A1	10-2002	Stockton et al.	396/429
*	B	US-7,137,073 B2	11-2006	Kim et al.	715/828
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
	O					
	P					
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